Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/905,300	TIEDEMANN ET AL.	
Examiner	Art Unit	
Soon D. Hyun	2661	

SEARCHED					
Class	Subclass	Date	Examiner		
	_				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		_			
L					

SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
Class, Subclass with Text Search See printout	9-14-05	4
Interference Search See Printout	9-14-05	۶
		·
	+	